



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Yamazaki, et al Art Unit : 2825
Serial No. : 09/894,950 Examiner : Caridad Everhart
Filed : June 27, 2001 Confirmation No.: 6263
Title : SEMICONDUCTOR DEVICE AND MANUFACTURING METHOD THEREOF

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

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INFORMATION DISCLOSURE STATEMENT

TECH CENTER 2800

Applicants submit the references listed on the attached form PTO-1449.

This statement is being filed after a first Office action on the merits, but before receipt of a final Office action or a Notice of Allowance. A check for \$180 in payment of the late submission fee of §1.17(p) is enclosed. Please apply any other charges or credits to Deposit Account No. 06-1050.

Respectfully submitted,

Date: July 21, 2004



John F. Hayden
Reg. No. 37,640

Customer No. 26171
Fish & Richardson P.C.
1425 K Street, N.W., 11th Floor
Washington, DC 20005-3500
Telephone: (202) 783-5070
Facsimile: (202) 783-2331

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Adjustment date: 07/23/2004 EABUBAK1
~~07/22/2004 EABUBAK1 00000026 09898950~~
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07/23/2004 EABUBAK1 00000113 09894950

01 FC:1806 180.00 DP

Substitute Form PTO-1449

U.S. Department of Commerce
Patent and Trademark OfficeAttorney's Docket No.
07977-280001Application No.
09/894,950**Information Disclosure Statement
by Applicant**

(Use several sheets if necessary)

(37 CFR § 1.318(b))

Applicant
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U.S. Patent Documents

Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA	5,886,364	03/23/1999	Zhang			
	AB	6,198,133 B1	03/06/2001	Yamazaki et al.			
	AC	6,340,830 B1	01/22/2002	Takemura			
	AD	6,392,255 B1	05/21/2002	Shibata et al.			
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	AG						
	AH						
	AI						
	AJ						
	AK						

Foreign Patent Documents or Published Foreign Patent Applications

Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
	AL	EP 1 081 676 A1	03/07/2001	EUROPE			In English	
	AM	EP 1 087 438 A2	03/28/2001	EUROPE			In English	
	AN							
	AO							
	AP							

Other Documents (include Author, Title, Date, and Place of Publication)

Examiner Initial	Desig. ID	Document
	AQ	
	AR	
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Examiner Signature

Date Considered

EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.